



# 80V 175°C N-CHANNEL ENHANCEMENT MODE MOSFET PowerDI5060-8

### **Product Summary**

		ID	
BVDSS	RDS(ON)	Tc = +25°C	
		(Note 11)	
80V	$4m\Omega$ @ $V_{GS} = 10V$	100A	

## **Description and Applications**

This new generation MOSFET is designed to minimize  $R_{DS(ON)}$ , yet maintain superior switching performance. This device is ideal for use in power management and load switch.

- DC-DC Converters
- Load Switch

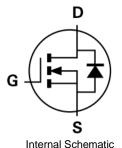
#### **Features**

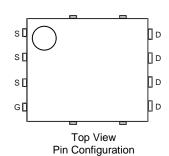
- Rated to +175°C Ideal for High Ambient Temperature Environments
- 100% Unclamped Inductive Switching (UIS) Test in Production Ensures More Reliable and Robust End Application
  - High Conversion Efficiency
- Low R<sub>DS(ON)</sub> Minimizes On State Losses
- Lead-Free Finish; RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- For automotive applications requiring specific change control (i.e. parts qualified to AEC-Q100/101/200, PPAP capable, and manufactured in IATF 16949 certified facilities), please contact us or your local Diodes representative. https://www.diodes.com/quality/product-definitions/

#### **Mechanical Data**

- Case: PowerDI<sup>®</sup>5060-8
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram Below
- Terminals: Finish Matte Tin Annealed over Copper Leadframe.
   Solderable per MIL-STD-202, Method 208 ©3
- Weight: 0.097 grams (Approximate)







### **Ordering Information** (Note 4)

Part Number	Case	Packaging
DMTH84M1SPS-13	PowerDI5060-8	2,500 / Tape & Reel

Notes:

- 1. EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant. All applicable RoHS exemptions applied.
- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/

## **Marking Information**



⊃¦¦= Manufacturer's Marking TH84M1SPS = Product Type Marking Code YYWW = Date Code Marking YY = Year (ex: 19 = 2019) WW = Week (01 to 53)

PowerDI is a registered trademark of Diodes Incorporated.



#### **Maximum Ratings** (@Tc = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit
Drain-Source Voltage	$V_{DSS}$	80	V
Gate-Source Voltage	Vgss	±20	V
Continuous Drain Current, V <sub>GS</sub> = 10V (Note 7)	lo	100 100	Α
Maximum Continuous Body Diode Forward Current (No	Is	83	Α
Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%)	Ірм	400	Α
Pulsed Body Diode Forward Current (10µs Pulse, Duty	I <sub>SM</sub>	400	Α
Avalanche Current, L = 1mH (Note 8)	las	23	Α
Avalanche Energy, L = 1mH (Note 8)	Eas	264.5	mJ

### Thermal Characteristics (@Tc = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Unit
Total Power Dissipation (Note 5)	T <sub>A</sub> = +25°C	$P_D$	1.6	W
Thermal Resistance, Junction to Ambient (Note 5)	Steady State	RθJA	96	°C/W
Total Power Dissipation (Note 6)	T <sub>A</sub> = +25°C	PD	2.8	W
Thermal Resistance, Junction to Ambient (Note 6)	Steady State	RθJA	53	°C/W
Total Power Dissipation (Note 7)	T <sub>C</sub> = +25°C	P <sub>D</sub>	136	W
Thermal Resistance, Junction to Case (Note 7)		R <sub>θ</sub> JC	1.1	°C/W
Operating and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to +175	°C

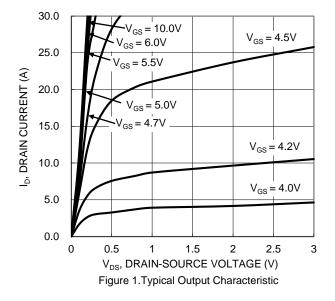
# **Electrical Characteristics** (@T<sub>C</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 9)							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	80	_	_	V	$V_{GS} = 0V$ , $I_D = 1mA$	
Zero Gate Voltage Drain Current	IDSS		_	1	μΑ	V <sub>DS</sub> = 64V, V <sub>GS</sub> = 0V	
Gate-Source Leakage	Igss	_	_	±100	nA	$V_{GS} = \pm 20V$ , $V_{DS} = 0V$	
ON CHARACTERISTICS (Note 9)	· · · · · · · · · · · · · · · · · · ·						
Gate Threshold Voltage	V <sub>GS(TH)</sub>	2	_	4	V	$V_{DS} = V_{GS}$ , $I_D = 250\mu A$	
Static Drain-Source On-Resistance		_	3.1	4	mΩ	Vgs = 10V, ID = 20A	
Static Dialii-Source Off-Resistance	Rds(on)	_	4.4	5.7	11122	V <sub>G</sub> S = 6V, I <sub>D</sub> = 20A	
Diode Forward Voltage	VsD		0.8	1.2	V	V <sub>G</sub> S = 0V, I <sub>S</sub> = 20A	
DYNAMIC CHARACTERISTICS (Note 10)							
Input Capacitance	Ciss		4209	_		V <sub>DS</sub> = 40V, V <sub>GS</sub> = 0V, f = 1MHz	
Output Capacitance	Coss		1513	_	pF		
Reverse Transfer Capacitance	Crss		62	_			
Gate Resistance	Rg	_	2.2	_	Ω	$V_{DS} = 0V$ , $V_{GS} = 0V$ , $f = 1MHz$	
Total Gate Charge (VGS = 6V)	Qg	_	41	_			
Total Gate Charge (V <sub>GS</sub> = 10V)	Qg	_	63	_	nC	\/ 40\/ I- 20A	
Gate-Source Charge	Qgs	_	17	_	iiC	$V_{DS} = 40V, I_{D} = 20A$	
Gate-Drain Charge	$Q_{gd}$		16	_		!	
Turn-On Delay Time	tD(ON)		16	_		$V_{DD} = 40V, V_{GS} = 10V,$ $I_{D} = 20A, R_{G} = 6\Omega$	
Turn-On Rise Time	t <sub>R</sub>		24	_			
Turn-Off Delay Time	tD(OFF)		53	_	ns		
Turn-Off Fall Time	tF		31	_			
Body Diode Reverse Recovery Time	t <sub>RR</sub>		56	_	ns I con II/II 1001/		
Body Diode Reverse Recovery Charge	QrR	-	100	_	nC	$I_S = 20A$ , di/dt = 100A/ $\mu$ s	

5. Device mounted on FR-4 PC board, with minimum recommended pad layout, single sided. Notes:

- 6. Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate.
  7. Thermal resistance from junction to soldering point (on the exposed drain pad).
- 8.  $I_{AS}$  and  $E_{AS}$  ratings are based on low frequency and duty cycles to keep  $T_J$  = +25°C.
- 9. Short duration pulse test used to minimize self-heating effect.
- Guaranteed by design. Not subject to product testing.
   Package limited.





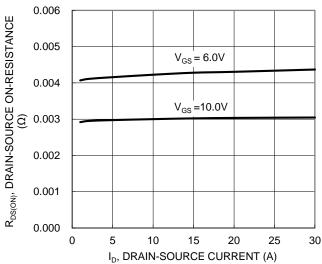


Figure 3. Typical On-Resistance vs. Drain Current and Gate Voltage

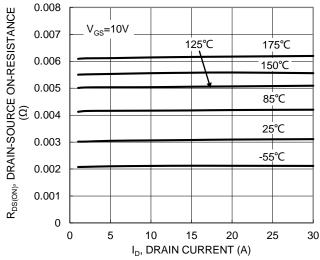
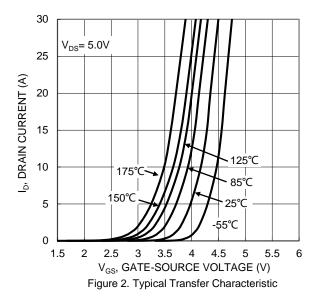
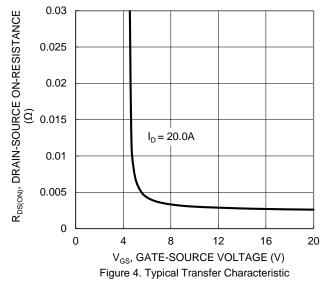


Figure 5. Typical On-Resistance vs. Drain Current and Temperature





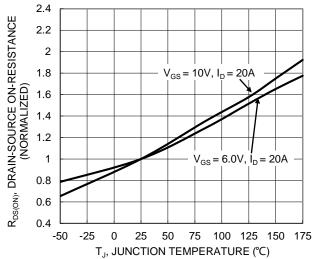


Figure 6. On-Resistance Variation with Temperature





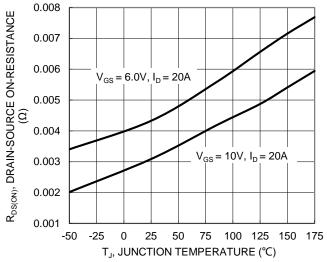


Figure 7. On-Resistance Variation with Temperature

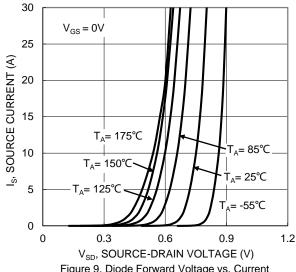
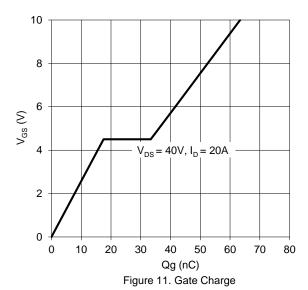
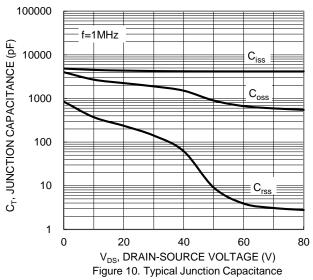


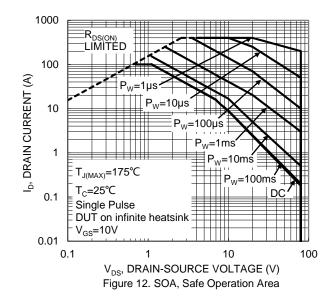
Figure 9. Diode Forward Voltage vs. Current



3.6  $V_{GS(TH)},\; GATE\; THRESHOLD\; VOLTAGE\; (V)$ 3.4 3.2 3 2.8 2.6 2.4  $I_D = 1mA$ 2.2 2  $I_{D} = 250 \mu A$ 1.8 1.6 1.4 1.2 1 0.8 0.6 -50 -25 0 25 50 75 100 125 150 175 T<sub>J</sub>, JUNCTION TEMPERATURE (°C)

Figure 8. Gate Threshold Variation vs. **JunctionTemperature** 





December 2019



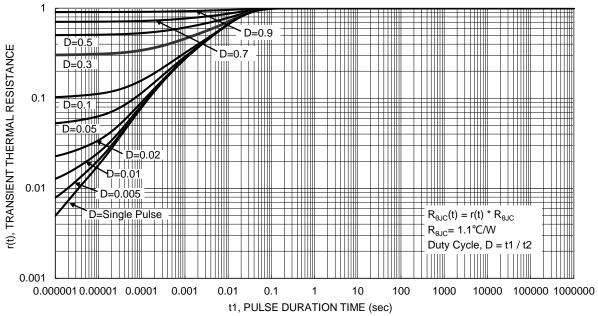


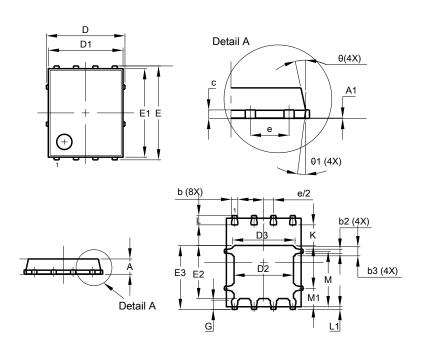
Figure 13. Transient Thermal Resistance



# **Package Outline Dimensions**

Please see http://www.diodes.com/package-outlines.html for the latest version.

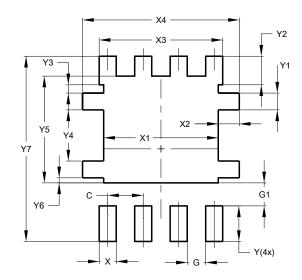
#### PowerDI5060-8



PowerDI5060-8					
Dim	Min	Max	Тур		
Α	0.90	1.10	1.00		
A1	0.00	0.05	-		
b	0.33	0.51	0.41		
b2	0.200	0.350	0.273		
b3	0.40	0.80	0.60		
С	0.230	0.330	0.277		
D	;	5.15 BSC	;		
D1	4.70	5.10	4.90		
D2	3.70	4.10	3.90		
D3	3.90 4.30 4.10				
Е	6.15 BSC				
E1	5.60	6.00	5.80		
E2	3.28	3.68	3.48		
E3	3.99	4.39	4.19		
е	1.27 BSC				
G	0.51	0.71	0.61		
K	0.51	-	-		
L	0.51	0.71	0.61		
L1	0.100	0.200	0.175		
М	3.235	4.035	3.635		
M1	1.00	1.40	1.21		
Θ	10°	12°	11°		
Θ1	6°	8°	7°		
All Dimensions in mm					

# **Suggested Pad Layout**

#### PowerDI5060-8



Dimensions	Value (in mm)			
С	1.270			
G	0.660			
G1	0.820			
X	0.610			
X1	4.100			
X2	0.755			
Х3	4.420			
X4	5.610			
Υ	1.270			
Y1	0.600			
Y2	1.020			
Y3	0.295			
Y4	1.825			
Y5	3.810			
Y6	0.180			
Y7	6.610			



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